



# NPN MEDIUM POWER SILICON TRANSISTOR

Qualified per MIL-PRF-19500/393

### DESCRIPTION

This family of high-frequency, epitaxial planar transistors feature low saturation voltage. These devices are also available in TO-39 and low profile U4 packaging. Microsemi also offers numerous other transistor products to meet higher and lower power ratings with various switching speed requirements in both through-hole and surface-mount packages.

Important: For the latest information, visit our website http://www.microsemi.com.

#### **FEATURES**

- JEDEC registered 2N3418 through 2N3421 series.
- JAN, JANTX, and JANTXV qualifications are available per MIL-PRF-19500/393.
- RoHS compliant versions available (commercial grade only).
- $\bullet ~~V_{CE(sat)} = 0.25 \; V \; @ \; I_C = 1 \; A. \label{eq:VcE}$
- Rise time  $t_r$  = 0.22  $\mu s$  max @  $I_C$  = 1.0 A,  $I_{B1}$  = 100 mA.
- Fall time  $t_{f}$  = 0.20  $\mu s$  max @ I\_C = 1.0 A, I\_{B2} = -100 mA.

### **APPLICATIONS / BENEFITS**

- General purpose transistors for medium power applications requiring high frequency switching and low package profile.
- Military and other high-reliability applications.

# **MAXIMUM RATINGS**

Parameters / Test Conditions	Symbol	2N3418 2N3420	2N3419 2N3421	Unit
Collector-Emitter Voltage	$V_{CEO}$	60	80	V
Collector-Base Voltage	V <sub>CBO</sub>	85	125	V
Emitter-Base Voltage	$V_{\text{EBO}}$	8		V
Collector Current tp <= 1 ms, duty cycle <= 50%	Ι <sub>C</sub>		3 5	A
Total Power Dissipation	PD	Į	1 5	W
Operating & Storage Junction Temperature Range	$T_J,T_stg$	-65 to	+200	°C

**Notes:** 1. Derate linearly 5.72 mW/°C for  $T_A > +25$  °C.

2. Derate linearly 150 mW/°C for  $T_C > +100$  °C.

<u>Qualified Levels</u>: JAN, JANTX and JANTXV



**TO-5** Package

Also available in:

TO-39 package (short leaded) 2N34185 - 2N34215

U4 package (surface mount) 2N3418U4 – 2N3421U4

MSC – Lawrence

6 Lake Street, Lawrence, MA 01841 Tel: 1-800-446-1158 or (978) 620-2600 Fax: (978) 689-0803

#### MSC – Ireland

Gort Road Business Park, Ennis, Co. Clare, Ireland Tel: +353 (0) 65 6840044 Fax: +353 (0) 65 6822298

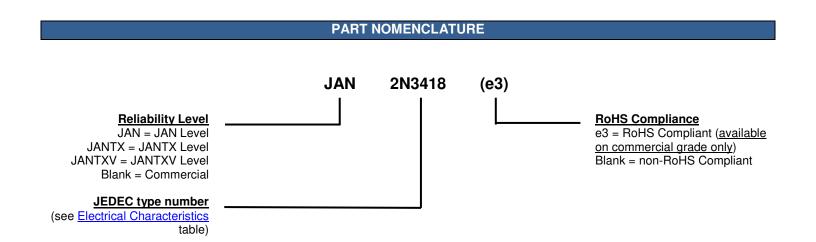
#### Website:

www.microsemi.com



# MECHANICAL and PACKAGING

- CASE: Hermetically sealed, kovar base, nickel cap
- MARKING: Part number, date code, manufacturer's ID
- POLARITY: See <u>Package Dimensions</u> on last page.



	SYMBOLS & DEFINITIONS				
Symbol	Definition				
C <sub>obo</sub>	Common-base open-circuit output capacitance.				
I <sub>CEO</sub>	Collector cutoff current, base open.				
I <sub>CEX</sub>	Collector cutoff current, circuit between base and emitter.				
I <sub>EBO</sub>	Emitter cutoff current, collector open.				
h <sub>FE</sub>	Common-emitter static forward current transfer ratio.				
V <sub>CEO</sub>	Collector-emitter voltage, base open.				
V <sub>CBO</sub>	Collector-emitter voltage, emitter open.				
V <sub>EBO</sub>	Emitter-base voltage, collector open.				



# **ELECTRICAL CHARACTERISTICS** ( $T_A = +25^{\circ}C$ , unless otherwise noted)

# **OFF CHARACTERISTICS**

Parameters / Test Conditions		Symbol	Min.	Max.	Unit
Collector-Emitter Breakdown Current					
$I_{\rm C} = 50 \text{ mA}, I_{\rm B} = 0$	2N3418, 2N3420 2N3419, 2N3421	V <sub>(BR)CEO</sub>	60 80		V
Collector-Emitter Cutoff Current					
	2N3418, 2N3420 2N3419, 2N3421	I <sub>CEX</sub>		0.3 0.3	μΑ
Collector-Base Cutoff Current					
$V_{CE} = 45 \text{ V}, I_B = 0$ $V_{CE} = 60 \text{ V}, I_B = 0$	2N3418, 2N3420 2N3419, 2N3421	I <sub>CEO</sub>		5.0 5.0	μA
Emitter-Base Cutoff Current $V_{EB} = 6.0 \text{ V}, I_C = 0$ $V_{EB} = 8.0 \text{ V}, I_C = 0$		I <sub>EBO</sub>		0.5 10	μΑ

# ON CHARACTERISTICS (1)

Parameters / Test Conditions	Symbol	Min.	Max.	Unit	
Forward-Current Transfer Ratio					
$I_{C} = 100 \text{ mA}, V_{CE} = 2.0 \text{ V}$	2N3418, 2N3419 2N3420, 2N3421		20 40		
$I_{C} = 1.0 \text{ A}, V_{CE} = 2.0 \text{ V}$	2N3418, 2N3419 2N3420, 2N3421	h <sub>FF</sub>	20 40	60 120	
$I_{\rm C}$ = 2.0 A, $V_{\rm CE}$ = 2.0 V	2N3418, 2N3419 2N3420, 2N3421		15 30		
$I_{C} = 5.0 \text{ A}, V_{CE} = 5.0 \text{ V}$	2N3418, 2N3419 2N3420, 2N3421		10 15		
Collector-Emitter Saturation Voltage					
$I_{\rm C} = 1.0 \text{ A}, I_{\rm B} = 0.1 \text{ A}$		V <sub>CE(sat)</sub>		0.25	V
$I_{\rm C} = 2.0 \text{ A}, I_{\rm B} = 0.2 \text{ A}$				0.5	
Base-Emitter Saturation Voltage					
$I_{\rm C} = 1.0 \text{ A}, I_{\rm B} = 0.1 \text{ A}$		V <sub>BE(sat)</sub>	0.6	1.2	V
$I_{\rm C} = 2.0 \text{ A}, I_{\rm B} = 0.2 \text{ A}$			0.7	1.4	

## **DYNAMIC CHARACTERISTICS**

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
Magnitude of Common Emitter Small-Signal Short Circuit Forward Current Transfer Ratio $I_{C} = 0.1 \text{ A}, V_{CE} = 10 \text{ V}, f = 20 \text{ MHz}$	h <sub>fe</sub>	1.3	0.8	
Output Capacitance $V_{CB}$ = 10 V, $I_{E}$ = 0, 100 kHz $\leq$ f $\leq$ 1.0 MHz	$C_{obo}$		150	pF

**NOTES:** (1) Pulse Test: Pulse Width = 300  $\mu s,$  Duty Cycle  $\leq$  2.0%.



# **ELECTRICAL CHARACTERISTICS** ( $T_A = +25^{\circ}C$ , unless otherwise noted) continued

## SWITCHING CHARACTERISTICS

Parameters / Test Conditions (for all symbols)		Symbol	Min.	Max.	Unit
Delay Time Rise Time	$V_{BE(off)} = -3.7 \text{ V},$ I <sub>C</sub> = 1.0 A, I <sub>B1</sub> = 100 mA	t <sub>d</sub> t <sub>r</sub>		0.08 0.22	μs
Storage Time Fall Time	$V_{BE(off)} = -3.7 \text{ V},$ I <sub>C</sub> = 1.0 A, I <sub>B2</sub> = -100 mA	t <sub>s</sub> t <sub>f</sub>		1.10 0.20	μs
Turn-Off Time	$V_{BE(off)} = -3.7 \text{ V}, I_{C} = 1.0 \text{ A},$ $I_{B2} = -100 \text{ mA}, R_{L} = 20 \Omega$	t <sub>off</sub>	t <sub>off</sub>	1.20	μs

## SAFE OPERATING AREA

DC Test	
T <sub>C</sub> = +100 °C, 1 cycle, t ≥ 1.0 s	
Test 1	
$V_{CE} = 5.0 \text{ V}, I_{C} = 3.0 \text{ A}$	
Test 2	
$V_{CE} = 37 \text{ V}, I_{C} = 0.4 \text{ A}$	
Test 3	
$V_{CE} = 60 \text{ V}, I_{C} = 0.185 \text{ A}$	2N3418, 2N3420
$V_{CE} = 80 \text{ V}, I_{C} = 0.12 \text{ A}$	2N3419, 2N3421
Clamped Switching	$T_A = +25 \text{ °C}, I_B = 0.5 \text{ A}, I_C = 3.0 \text{ A}$



GRAPHS

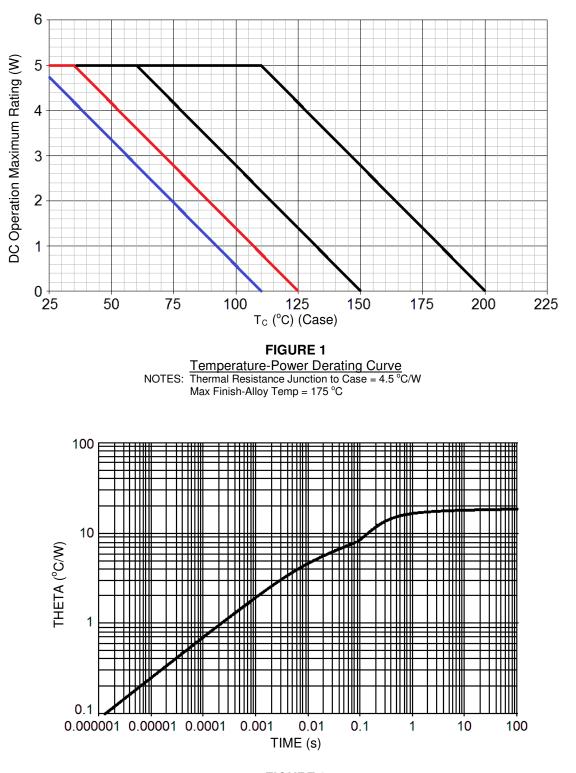
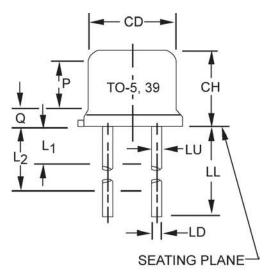


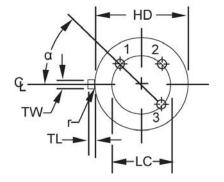
FIGURE 2 <u>Maximum Thermal Impedance</u> NOTE:  $T_c = +25 \text{ °C}$ , Thermal Resistance  $R_{euc} = 4.5 \text{ °C/W}$ 



# PACKAGE DIMENSIONS



	Dimensions				
Symbol	In	Inch		Millimeters	
-	Min	Max	Min	Max	
CD	.305	.335	7.75	8.51	
СН	.240	.260	6.10	6.60	
HD	.335	.370	8.51	9.40	
LC	.200	) TP	5.08	3 TP	6
LD	.016	.021	0.41	0.53	
LL	.500	.750	12.7	19.05	7
LU		See notes	s 7, 13, 14	1	
L <sub>1</sub>		.050		1.27	7
$L_2$	.250		6.35		7
Р	.100		2.54		5
Q		.040		1.02	4
TL	.029	.045	0.74	1.14	3, 10
TW	.028	.034	0.71	.86	9, 10
r		.010		0.25	11
α	45°	TP	45° TP		6



- 1. Dimensions are in inches.
- 2. Millimeters are given for general information only.
- 3. Symbol TL is measured from HD maximum.
- 4. Details of outline in this zone are optional.
- 5. Symbol CD shall not vary more than .010 inch (0.25 mm) in zone P. This zone is controlled for automatic handling.
- 6. Léads at gauge plane .054 inch (1.37 mm) +.001 inch (0.03 mm) -.000 inch (0.00 mm) below seating plane shall be within .007 inch (0.18 mm) radius of TP relative to tab. Device may be measured by direct methods or by gauge.
- 7. Symbol LU applies between L1 and L2. Dimension LD applies between L2 and LL minimum. Diameter is uncontrolled in L1 and beyond LL minimum.
- 8. Lead number 3 is electrically connected to case.
- 9. Beyond r maximum, TW shall be held for a minimum length of .021 inch (0.53 mm).
- 10. Lead number 4 omitted on this variation.
- 11. Symbol r applied to both inside corners of tab.
- 12. For transistor types 2N3418, 2N3419, 2N3420, 2N3421, LL is 1.500 (38.10 mm) minimum, and 1.750 (44.45 mm) maximum.
- 13. In accordance with ASME Y14.5M, diameters are equivalent to  $\Phi x$  symbology.
- 14. Lead 1 is emitter, lead 2 is base, and lead 3 is collector.